

Practitioner's Docket No. MI22-2379

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PATENT

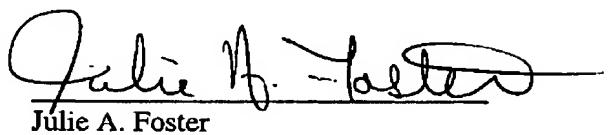
IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of: Warren M. Farnworth, et al.**Application No.:** 10/632,273
Filed: July 31, 2003**Group No.:** 2829
Examiner: Russell M. Kobert**Title:** Method and Apparatus for Testing Semiconductor Circuitry for Operability and Method of Forming Apparatus for Testing Semiconductor Circuitry for OperabilityCommissioner for Patents
Washington, D.C. 20231

CERTIFICATION OF FACSIMILE TRANSMISSION

I hereby certify that the following papers are being facsimile transmitted to the Patent and Trademark Office at (571) 273-8300 on the date shown below:

1. Facsimile Transmittal
2. Examiner Interview Summary of September 7, 2005

September 13, 2005
Date
Julie A. FosterTotal Pages: 3**Although it is believed that no fees are due, the Commissioner is hereby authorized to charge any fees under 37 C.F.R. 1.16 and 1.17 which may be required by this paper to Deposit Account No. 23-0925.**

(Certification of Facsimile Transmission--page 1 of 1)

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Application Serial No. 10/632,273
Filing Date July 31, 2003
Inventor Warren M. Farnworth, et al.
Assignee Micron Technology, Inc.
Group Art Unit 2829
Examiner Russell M. Kobert
Attorney's Docket No. MI22-2379
Customer No. 021567
Title: Method and Apparatus for Testing Semiconductor Circuitry for Operability and
Method of Forming Apparatus for Testing Semiconductor Circuitry for Operability

EXAMINER INTERVIEW SUMMARY OF SEPTEMBER 7, 2005

To: Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

From: D. Brent Kenady
Tel. 509-624-4276; Fax 509-838-3424
Wells St. John P.S.
601 West First Avenue, Suite 1300
Spokane, WA 99201-3828

Applicant's representative held an interview with Examiner Kobert on September 7, 2005. Applicant's representative would like to thank Examiner Kobert for his time and attention to this matter.

Applicant's representative directed Examiner's attention to the "selected portion of Figure 4" presented by the Examiner in the pending office action (pg. 3, paper no. 0605). Applicant's representative directed the Examiner's attention to an important inconsistency of the figure. That is, the figure illustrates an alleged "substrate (portion of 40)" and an

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alleged "lateral dimension of substrate" illustrated as a horizontal arrow which clearly does not correspond to a lateral dimension of the substrate. The Examiner stated he understood Applicant's position and encouraged the Applicant to describe the inconsistency in a subsequently-filed response. Applicant's representative stated he would do so.

Applicant's representative is greatly appreciative of Examiner Kobert's consideration of this matter.

Respectfully submitted,

Dated: 9-13-05

By:



D. Brent Kenady
Reg. No. 40,045